

PCTEST ENGINEERING LABORATORY, INC.

7185 Oakland Mills Road, Columbia, MD 21046 USA Tel. 410.290.6652 / Fax 410.290.6654 http://www.pctestlab.com



HEARING AID COMPATIBILITY

Applicant Name:

LG Electronics MobileComm U.S.A. Inc. 1000 Sylvan Avenue Englewood Cliffs, NJ 07632 United States Date of Testing: 01/23/2017 - 01/25/2017 Test Site/Location: PCTEST Lab, Columbia, MD, USA Test Report Serial No.: 1M1701230039-07.ZNF

FCC ID:

ZNFAS110

APPLICANT:

LG ELECTRONICS MOBILECOMM U.S.A. INC.

Scope of Test: Application Type: FCC Rule Part(s): HAC Standard:

DUT Type: Model: Additional Model(s): Test Device Serial No.: RF Emissions Testing Certification CFR §20.19(b) ANSI C63.19-2011 285076 D01 HAC Guidance v04 285076 D02 T-Coil testing for CMRS IP v02 Portable Handset LG-AS110 LGAS110, AS110 *Pre-Production Sample* [S/N: 02065]

C63.19-2011 HAC Category: M3 (RF EMISSIONS CATEGORY)

This wireless portable device has been shown to be hearing-aid compatible under the above rated category, specified in ANSI/IEEE Std. C63.19-2011 and has been tested in accordance with the specified measurement procedures. Hearing-Aid Compatibility is based on the assumption that all production units will be designed electrically identical to the device tested in this report. Test results reported herein relate only to the item(s) tested.

I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.

Randy Ortanez President



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1. INTRODUCTION

On July 10, 2003, the Federal Communications Commission (FCC) adopted new rules requiring wireless manufacturers and service providers to provide digital wireless phones that are compatible with hearing aids. The FCC has modified the exemption for wireless phones under the Hearing Aid Compatibility Act of 1998 (HAC Act) in WT Docket 01-309 RM-8658¹ to extend the benefits of wireless telecommunications to individuals with hearing disabilities. These benefits encompass business, social and emergency communications, which increase the value of the wireless network for everyone. An estimated more than 10% of the population in the United States show signs of hearing impairment and of that fraction, almost 80% use hearing aids. Approximately 500 million people worldwide suffer from hearing loss.

Compatibility Tests Involved:

The standard calls for wireless communications devices to be measured for:

- RF Electric-field emissions
- T-coil mode, magnetic-signal strength in the audio band
- T-coil mode, magnetic-signal frequency response through the audio band
- T-coil mode, magnetic-signal and noise articulation index

The hearing aid must be measured for:

- RF immunity in microphone mode
- RF immunity in T-coil mode

In the following tests and results, this report includes the evaluation for a wireless communications device.



Figure 1-1 Hearing Aid *in-vitu*

¹ FCC Rule & Order, WT Docket 01-309 RM-8658

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2. DUT DESCRIPTION



FCC ID: Manufacturer:

Model: Additional Model(s): Serial Number: Antenna Configurations: HAC Test Configurations: ZNFAS110 LG Electronics MobileComm U.S.A. Inc. 1000 Sylvan Avenue Englewood Cliffs, NJ 07632 United States LG-AS110 LGAS110, AS110 02065 Internal Antenna GSM 850, 128, 190, 251, BT Off, WLAN Off, LTE Off GSM 1900, 512, 661, 810, BT Off, WLAN Off, LTE Off Portable Handset

DUT Type:

Air-Interface	Band (MHz)	Type Transport	HAC Tested	Simultaneous But Not Tested	Voice over Digital Transport OTT Capability	Additional GSM Power Reduction
	850	VO	Yes	Yes: WIFI or BT	N/A	No
GSM	1900	VO	Tes	Tes. WIFI OF BT	N/A	NO
	GPRS/EDGE	DT	No	Yes: WIFI or BT	Yes	No
	1700		No ¹		NI / A	N1/A
UMTS	1900	VD	INO ⁷	Yes: WIFI or BT	N/A	N/A
	HSPA	DT	No	Yes: WIFI or BT	Yes	N/A
	700 (B12)			Yes: WIFI or BT	Yes	N/A
	850 (B5)	VD ³	No ^{1 2}			
LTE (FDD)	1700 (B4)					
	1900 (B2)					
WIFI	2450	VD	No ^{1 2}	Yes: GSM, UMTS, or LTE	Yes	N/A
BT	2450	DT	No	Yes: GSM, UMTS, or LTE	N/A	N/A
Type Transport VO = Voice Onl DT = Digital Da VD = CMRS and	y ta - Not intende		Notes: 1. Evaluated for MIF and low-power exemption. 1RS Service 2. No associated T-coil measurement has been made in accordance with the guidance issued by OET in KDB publication 285076 D02 T-Coil testing for CMRS IP. 3. The 3GPP VoLTE CMRS service is defined by GSMA in PRD IR.92 for IP Voice Service and Digital Transport.			

Table 2-1: ZNFAS110 HAC Air Interfaces

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3. ANSI/IEEE C63.19 PERFORMANCE CATEGORIES

I. RF EMISSIONS

The ANSI Standard presents performance requirements for acceptable interoperability of hearing aids with wireless communications devices. When these parameters are met, a hearing aid operates acceptably in close proximity to a wireless communications device.

Category	Telephone RF Parameters			
Near field Category	E-field emissions CW dB(V/m)			
	f < 960 MHz			
M1	50 to 55			
M2	45 to 50			
M3	40 to 45			
M4	< 40			
f > 960 MHz				
M1	40 to 45			
M2	35 to 40			
M3	30 to 35			
M4	< 30			
Table 3-1WD near-field categories as defined in ANSI C63.19-2011				

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4. SYSTEM SPECIFICATIONS

ER3DV6 E-Field Probe Description

Construction:	One dipole parallel, two dipoles normal to probe axis
Calibration:	Built-in shielding against static charges In air from 100 MHz to 3.0 GHz (absolute accuracy ±6.0%, k=2)
Frequency:	100 MHz to > 6 GHz;
	Linearity: ± 0.2 dB (100 MHz to 3 GHz)
Directivity	± 0.2 dB in air (rotation around probe axis)
	± 0.4 dB in air (rotation normal to probe axis)
Dynamic Range	2 V/m to > 1000 V/m
, ,	(M3 or better device readings fall well below diode
	compression point)
Linearity:	± 0.2 dB
Dimensions	Overall length: 330 mm (Tip: 16 mm)
	Tip diameter: 8 mm (Body: 12 mm)
	Distance from probe tip to dipole centers: 2.5 mm

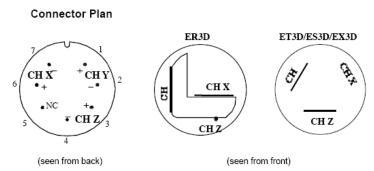


Figure 4-1 E-field Free-space Probe

Probe Tip Description

HAC field measurements take place in the close near field with high gradients. Increasing the measuring distance from the source will generally decrease the measured field values (in case of the validation dipole approx. 10% per mm).

The electric field probes have an irregular internal geometry because it is physically not possible to have the 3 orthogonal sensors situated with the same center. The effect of the different sensor centers is accounted for in the HAC uncertainty budget ("sensor displacement"). Their geometric center is at 2.5mm from the tip, and the element ends are 1.1mm closer to the tip.



The antistatic shielding inside the probe is connected to the probe connector case.

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Instrumentation Chain

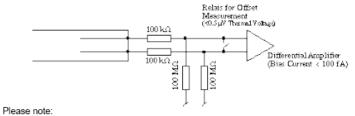
Equation 1 Conversion of Connector Voltage u_i to E-Field E_i

$$E_i = \sqrt{\frac{u_i + (u_i^2 \cdot CF)/(DCP)}{Norm_i \cdot ConvF}}$$

whereby

Ei:	electric field in V/m
Uj.	voltage of channel i at the connector in μV
Norm	sensitivity of channel i in μV/(V/m) ²
ConvF:	enhancement factor in liquid (ConvF=1 for Air)
DCP:	diode compression point in µV
CF:	signal crest factor (peak power/average power)

Conditions of Calibration



a lower input impedance of the amplifier will result in different sensitivity factors Norm, and DCP

larger bias currents will cause higher offset

Probe Response to Frequency

The E-field sensors have inherently a very flat frequency response. They are calibrated with a number of frequencies resulting in a common calibration factor, with the frequency behavior documented in the calibration certificate (See also below).

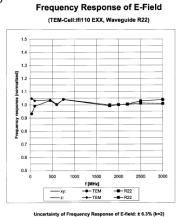


Figure 4-2 E-Field Probe Frequency Response

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SPEAG Robotic System

E-field measurements are performed using the DASY5 automated dosimetric assessment system. The DASY5 is made by Schmid & Partner Engineering AG (SPEAG) in Zurich, Switzerland and consists of high precision robotics system (Staubli), robot controller, Intel CORE i7 computer, near-field probe, probe alignment sensor, and the HAC phantom. The robot is a six-axis industrial robot performing precise movements to position the probe to the location (points) of maximum electromagnetic field (EMF).



Figure 4-3 SPEAG Robotic System

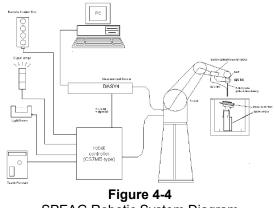
System Hardware

A cell controller system contains the power supply, robot controller, teach pendant (Joystick), and a remote control used to drive the robot motors. The PC consists of the computer with operating system and RF Measurement Software DASY5 v52.8 (with HAC Extension), A/D interface card, monitor, mouse, and keyboard. The Staubli Robot is connected to the cell controller to allow software manipulation of the robot. A data acquisition electronic (DAE) circuit that performs the signal amplification, signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. is connected to the Electro-optical coupler (EOC). The EOC performs the conversion from the optical into digital electric signal of the DAE and transfers data to the PC plug-in card.

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System Electronics

The DAE consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the PC-card is accomplished through an optical downlink for data and status information and an optical uplink for commands and clock lines. The mechanical probe mounting device includes two different sensor systems for frontal and sidewise probe contacts. They are also used for mechanical surface detection and probe collision detection. The robot uses its own controller with a built in VME-bus computer.



SPEAG Robotic System Diagram

DASY5 Instrumentation Chain

The first step of the evaluation is a linearization of the filtered input signal to account for the compression characteristics of the detector diode. The compensation depends on the input signal, the diode type and the DC-transmission factor from the diode to the evaluation electronics. If the exciting field is pulsed, the crest factor of the signal must be known to correctly compensate for peak power. The formula for each channel can be given as:

$$V_i = U_i + U_i^2 \cdot \frac{cf}{dcp_i}$$

with	V_i	= compensated signal of channel i	(i = x, y, z)
	U_i	= input signal of channel i	(i = x, y, z)
	cf	= crest factor of exciting field	(DASY parameter)
	dcp_i	= diode compression point	(DASY parameter)

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From the compensated input signals the primary field data for each channel can be evaluated:

$$\begin{array}{rcl} \mathrm{E-field probes}: & E_i = \sqrt{\frac{V_i}{Norm_i \cdot ConvF}} \\ \text{with} & V_i & = \mathrm{compensated\ signal\ of\ channel\ i} & (\mathrm{i}=\mathrm{x},\,\mathrm{y},\,\mathrm{z}) \\ Norm_i & = \mathrm{sensor\ sensitivity\ of\ channel\ i} & (\mathrm{i}=\mathrm{x},\,\mathrm{y},\,\mathrm{z}) \\ & \mu\mathrm{V}/(\mathrm{V/m})^2 \ \mathrm{for\ E-field\ Probes} \\ ConvF & = \mathrm{sensitivity\ enhancement\ in\ solution} \\ E_i & = \mathrm{electric\ field\ strength\ of\ channel\ i\ in\ V/m} \end{array}$$

The RSS value of the field components gives the total field strength (Hermitian magnitude):

$$E_{tot} = \sqrt{E_x^2 + E_y^2 + E_z^2}$$

The primary field data are used to calculate the derived field units.

The measurement/integration time per point, as specified by the system manufacturer is >500ms.

The signal response time is evaluated as the time required by the system to reach 90% of the expected final value after an on/off switch of the power source with an integration time of 500ms and a probe response time of <5 ms. In the current implementation, DASY5 waits longer than 100ms after having reached the grid point before starting a measurement, i.e., the response time uncertainty is negligible.

If the device under test does not emit a CW signal, the integration time applied to measure the electric field at a specific point may introduce additional uncertainties due to the discretization. The tolerances for the different systems had the worst-case of 2.6%.

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5. TEST PROCEDURE

I. RF EMISSIONS



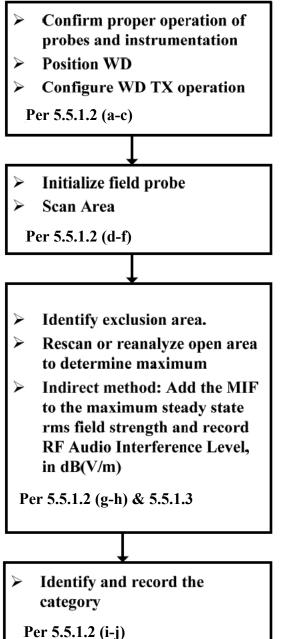
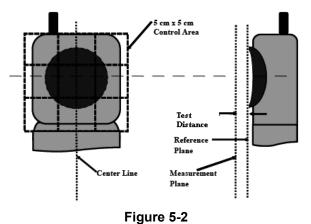


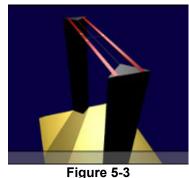
Figure 5-1 RF Emissions Flow Chart

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Test Setup



E-Field Emissions Test Setup Diagram (See Test Photographs for actual WD scan grid overlay)



HAC Phantom

RF Emissions Test Procedure:

The following illustrate a typical RF emissions test scan over a wireless communications device:

- 1. Proper operation of the field probe, probe measurement system, other instrumentation, and the positioning system was confirmed.
- 2. WD is positioned in its intended test position, acoustic output point of the device perpendicular to the field probe.
- The WD operation for maximum rated RF output power was configured and confirmed with the base station simulator, at the test channel and other normal operating parameters as intended for the test. The battery was ensured to be fully charged before each test.
- 4. The center sub-grid was centered over the center of the acoustic output (also audio band magnetic output, if applicable). The WD audio output was positioned tangent (as physically possible) to the measurement plane.
- 5. A surface calibration was performed before each setup change to ensure repeatable spacing and proper maintenance of the measurement plane using the HAC Phantom.
- 6. The measurement system measured the field strength at the reference location.
- 7. Measurements at 2mm or 5mm increments in the 5 x 5 cm region were performed at a distance 15 mm from the center point of the probe measurement element to the WD. A 360° rotation about the azimuth axis at the maximum interpolated position was measured. For the worst-case condition, the peak reading from this rotation was used in re-evaluating the HAC category.
- 8. The system performed a drift evaluation by measuring the field at the reference location. If the power drift deviated by more than 5%, the HAC test and drift measurements were repeated.

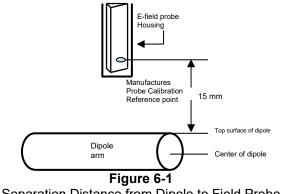
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6. SYSTEM CHECK

I. System Check Parameters

The input signal was an un-modulated continuous wave. The following points were taken into consideration in performing this check:

- Average Input Power P = 100mW RMS (20dBm RMS) after adjustment for return loss
- The test fixture must meet the 2 wavelength separation criterion
- The proper measurement of the 15 mm probe to dipole separation, which is measured from top surface of the dipole to the calibration reference point of the sensor, defined by the probe manufacturer is shown in the following diagram:



Separation Distance from Dipole to Field Probe

RF power was recorded using both an average reading meter and a peak reading meter. Readings of the probe are provided by the measurement system.

To assure proper operation of the near-field measurement probe the input power to the dipole shall be commensurate with the full rated output power of the wireless device [e.g. - for a cellular phone wireless device the average peak antenna input power will be on the order of 100mW (20dBm) RMS] after adjustment for any mismatch.

II. Validation Procedure

A dipole antenna meeting the requirements given in C63.19 was placed in the position normally occupied by the WD.

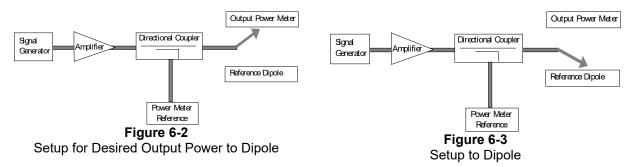
The length of the dipole was scanned, and the average peak value was recorded.

Measurement of CW

Using the near-field measurement system, scan the antenna over the radiating dipole and record the greatest field reading observed. Due to the nature of E-fields about free-space dipoles, the two E-field peaks measured over the dipole are averaged to compensate for non-parallelity of the setup (see manufacturer method on dipole calibration certificates, page 2). Field strength measurements shall be made only when the probe is stationary.

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RF power was recorded using both an average and a peak power reading meter.

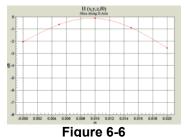


Using this setup configuration, the signal generator was adjusted for the desired output power (100mW) at a specified frequency. The reference power from the coupled port of the directional coupler is recorded. Next, the output cable is connected to the reference dipole, as shown in Figure 6-3.

The input signal level was adjusted until the reference power from the coupled port of the directional coupler was the same as previously recorded, to compensate for the impedance mismatch between the output cable and the reference dipole. To assure proper operation of the near-field measurement probe the input power to the reference dipole was verified to the full rated output power of the wireless device. The dipole was secured in a holder in a manner to meet the 20 dB reflection. The near-field measurement probe was positioned over the dipole. The antenna was scanned over the appropriate sized area to cover the dipole from end to end. SPEAG uses 2D interpolation algorithms between the measured points. Please see below two dimensional plots showing that the interpolated values interpolate smoothly between 5mm steps for a free-space RF dipole:



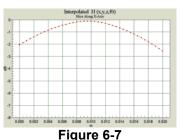
2-D Raw Data from scan along dipole axis



2-D Raw Data from scan along transverse axis



2-D Interpolated points from scan along dipole axis



2-D Interpolated points from scan along transverse axis

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III. System Check Results

Validation Results

Frequency (MHz)	Dipole S/N	Input Power (dBm)	E-field Result (V/m)	Target Field (V/m)	% Deviation
835	1082	20.0	115.8	106.8	8.4%
1880	1064	20.0	96.0	89.6	7.1%

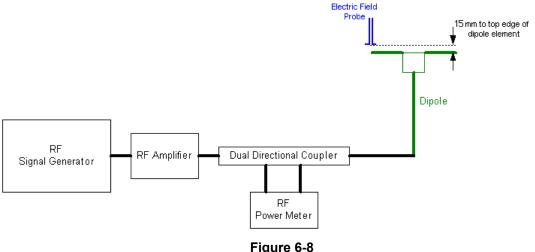


Figure 6-8 System Check Setup

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7. MODULATION INTERFERENCE FACTOR

I. Measuring Modulation Interference Factors

For any specific fixed and repeatable modulated signal, a modulation interference factor (MIF, expressed in dB) may be determined that relates its interference potential to its steady-state RMS signal level or average power level. This factor is a function only of the audio-frequency amplitude modulation characteristics of the signal and is the same for field-strength and conducted power measurements. The MIF is valid only for a specific repeatable audio-frequency amplitude modulation characteristic; any change in modulation characteristic requires determination and application of a new MIF.

The MIF may be determined using a radiated RF field or a conducted RF signal:

- a. Using RF illumination or conducted coupling, apply the specific modulated signal in question to the measurement system at a level within its confirmed operating dynamic range.
- b. Measure the steady-state RMS level at the output of the fast probe or sensor.
- c. Measure the steady-state average level at the weighting output.
- d. Without changing the square-law detector or weighting system, and using RF illumination or conducted coupling, substitute for the specific modulated signal a 1 kHz, 80% amplitude modulated carrier at the same frequency and adjust its strength until the level at the weighting output equals the step c) measurement.
- e. Without changing the carrier level from step d), remove the 1 kHz modulation and again measure the steady-state RMS level indicated at the output of the fast probe or sensor.
- f. The MIF for the specific modulation characteristic is provided by the ratio of the step e) measurement to the step b) measurement, expressed in dB (20 × log[(step e)/(step b)]).

The following procedure was used to measure the MIF using the SPEAG Audio Interference Analyzer (AIA), Type No: SE UMS 170 CB, Serial No.: 1010:

- 1. The device was placed into a simulated call using a base station simulator or set to transmit using test software for a given mode.
- 2. The device was then set to continuously transmit at maximum power.
- 3. Using a coupler if needed, the device output signal was connected to the RF In port of the AIA, which was connected to a desktop computer. Alternatively, a radiated RF signal may be used with the AIA's built-in antenna.
- 4. The MIF measurement procedure in the DASY software was run, and the resulting MIF value was recorded.
- 5. Steps 1-4 were repeated for all CMRS air interfaces, frequency bands, and modulations.

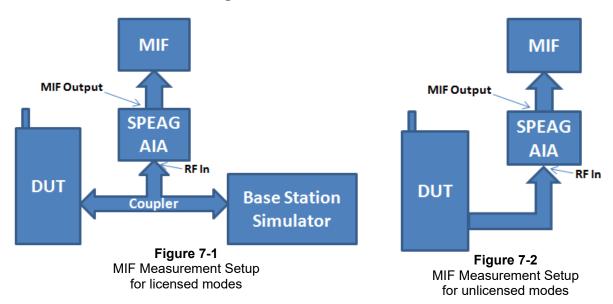
The modulation interference factors obtained were applied to readings taken of the actual wireless device in order to obtain an accurate audio interference level reading using the formula:

Audio Interference Level [dB(V/m)] = 20 * log[Raw Field Value (V/m)] + MIF (dB)

Because the MIF value is output power independent, MIF values for a given mode should be constant across all devices; however, per C63.19-2011 §D.7, MIF values should be measured for each device being evaluated. The voice modes for this device have been investigated in this section of the report.

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II. MIF Measurement Block Diagrams



III. Measured Modulation Interference Factors:

 Table 7-1

 GSM Modulation Interference Factors¹

Mode	GSM850			GSM1900		
	128	190	251	512	661	810
GSM	3.53	3.53	3.53	3.54	3.53	3.54

 Table 7-2

 UMTS Modulation Interference Factors¹

Mode			UMTS IV			UMTS II		
		1312	1412	1513	9262	9400	9538	
	12.2 kbps RMC	-25.42	-25.59	-25.76	-26.88	-26.93	-23.87	
UMTS	12.2 kbps AMR	-13.00	-12.91	-12.99	-12.93	-12.86	-13.81	

¹ Note: Measured MIF values may be lower than sample MIF values provided in ANSI C63.19-2011 Annex D.7 Table D.5 due to manufacturing variations for each device, however per Annex D.7, the sample MIF values of Table D.5 are not intended to substitute for measurements of actual devices under test and their respective operating modes.

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LTE Band	Frequency [MHz]	Channel	Bandwidth [MHz]	Modulation	RB Size	RB Offset	MIF [dB]
12	707.5	23095	10	16QAM	1	0	-9.73
5	836.5	20525	10	16QAM	1	0	-10.56
4	1732.5	20175	20	16QAM	1	0	-9.96
2	1880.0	18900	20	16QAM	1	0	-9.72
2	1880.0	18900	20	QPSK	1	0	-14.59
2	1880.0	18900	20	16QAM	1	50	-9.84
2	1880.0	18900	20	16QAM	1	99	-9.85
2	1880.0	18900	20	16QAM	50	0	-16.45
2	1880.0	18900	20	16QAM	100	0	-17.39
2	1880.0	18900	15	16QAM	1	0	-9.54
2	1880.0	18900	10	16QAM	1	0	-9.63
2	1880.0	18900	5	16QAM	1	0	-9.43
2	1880.0	18900	3	16QAM	1	0	-9.54
2	1880.0	18900	1.4	16QAM	1	0	-10.38
2	1880.0	18625	5	16QAM	1	0	-9.55
2	1880.0	19175	5	16QAM	1	0	-10.68

 Table 7-3

 LTE FDD Modulation Interference Factors^{1,3}

Table 7-4 802.11b (2.4GHz, SISO) Modulation Interference Factors^{1,2} 802 11b MIE Measurements [dB]

	SU2. TID WIF Measurements [dB]							
Mode	Data Rate [Mbps]							
	1	2	5.5	11				
802.11b	-16.10	-15.77	-12.32	-12.21				

Table 7-5

802.11g (2.4GHz, SISO) Modulation Interference Factors^{1,2}

	Ŭ		802.1	1g MIF Me	asurement	s [dB]		
Mode	Data Rate [Mbps]							
	6	9	12	18	24	36	48	54
802.11g	-14.25	-13.70	-13.22	-12.27	-12.01	-11.68	-11.91	-12.15

Table 7-6

802.11n (2.4GHz, SISO) Modulation Interference Factors^{1,2}

	802.11n (2.4GHz) MIF Measurements [dB]							
Mode		Data Rate [Mbps]						
	6.5	13	19.5	26	39	52	58.5	65
802.11n	-14.17	-13.01	-12.55	-12.15	-11.93	-12.25	-12.46	-12.64

¹ Note: Measured MIF values may be lower than sample MIF values provided in ANSI C63.19-2011 Annex D.7 Table D.5 due to manufacturing variations for each device, however per Annex D.7, the sample MIF values of Table D.5 are not intended to substitute for measurements of actual devices under test and their respective operating modes.

² Note: WLAN MIF values were found to be independent of the transmit channel.

³ Note: All LTE bands were found to have substantially similar MIF values given similar RB, BW, and modulation configurations.

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8. **RF CONDUCTED POWER MEASUREMENTS**

I. Procedures Used to Establish RF Signal for HAC Testing

The handset was placed into a simulated call using a base station simulator in a shielded chamber. Such test signals offer a consistent means for testing HAC and are recommended for evaluating HAC. Measurements were taken with a fully charged battery. In order to verify that the device was tested and maintained at full power, this was configured with the base station simulator.

II. HAC Measurement Conditions

Output Power Verification

Maximum output power is verified on the High, Middle and Low channels for all applicable air interfaces. See Table 8-1 for air interface specific settings of transmit power parameters.

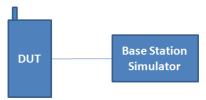
Air Interface:	Parameter Name:	Parameter Set To:
GSM	PCL	GSM850: "5"; GSM1900: "0"
UMTS	TPC	"All 1's"
LTE	TPC	"Max Power"
WLAN	Mfr Configured	Mfr Specified

Table 8-1

Power Control Parameters and Settings by Air Interface

III. Setup Used to Measure RF Conducted Powers

Power measurements for licensed modes were performed using a base station simulator under digital average power. Power measurements for unlicensed modes were performed using a power meter and power sensor.



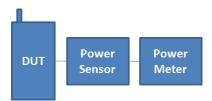
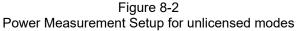


Figure 8-1 Power Measurement Setup for licensed modes



IV. GSM Conducted Powers

Band	Channel	GSM [dBm] CS (1 Slot)
	128	33.43
GSM 850	190	33.27
	251	33.35
	512	29.67
GSM 1900	661	29.53
	810	29.58

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V. UMTS Conducted Powers

Mode	AW	AWS Band [dBm]			PCS Band [dBm]		
	1312	1412	1513	9262	9400	9538	
12.2 kbps RMC	23.08	23.08	23.03	23.05	23.04	23.05	
12.2 kbps AMR	23.04	23.08	23.03	23.07	23.09	23.10	

VI. LTE Conducted Powers

a. LTE Band 12

L]	Table 8-2 LTE Band 12 (707.5MHz) Conducted Powers – 10MHz Bandwidth											
	10 MHz Bandwidth Mid Channel											
	Modulation	RB Size	RB Offset	23095	MPR Allowed per	MDD (4D)						
	wodulation	KD SIZE	RB Oliset	(707.5 MHz) Conducted Power [dBm]	3GPP [dB]	MPR [dB]						
ľ		1	0	24.39		0						
		1	25	24.56	0	0						
		1	49	24.32	-	0						
	QPSK	25	0	23.52		1						
		25	12	23.66	0-1	1						
		25	25	23.50	0-1	1						
		50	0	23.49		1						
		1	0	23.54		1						
		1	25	23.55	0-1	1						
		1	49	23.43		1						
	16QAM	25	0	22.59		2						
		25	12	22.52	0-2	2						
		25	25	22.48	0-2	2						
		50	0	22.35		2						

Note: Since LTE Band 12 at 10MHz bandwidth does not support 3 non-overlapping channels, conducted power measurements were made only on the middle channel.

				LTE Band 12		Ballamati	
				5 MHz Bandwidth			
			Low Channel	Mid Channel	High Channel		
Modulation	RB Size	RB Offset	23035 (701.5 MHz)	23095 (707.5 MHz)	23155 (713.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			1	Conducted Power [dBm]		
	1	0	24.30	24.64	24.16		0
	1	12	24.42	24.62	24.63	0	0
QPSK	1	24	24.40	24.52	24.26		0
	12	0	23.46	23.51	23.54		1
	12	6	23.55	23.51	23.51	0-1	1
	12	13	23.64	23.63	23.41		1
	25	0	23.60	23.61	23.53	1 –	1
	1	0	23.39	23.41	23.40		1
	1	12	23.34	23.50	23.48	0-1	1
	1	24	23.54	23.41	23.39	1	1
16QAM	12	0	22.45	22.56	22.42		2
	12	6	22.46	22.61	22.60		2
	12	13	22.65	22.60	22.50	0-2	2
	25	0	22.64	22.63	22.60	1 [2

 Table 8-3

 LTE Band 12 (707.5MHz) Conducted Powers – 5MHz Bandwidth

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				LTE Band 12 3 MHz Bandwidth			
			Low Channel	Mid Channel	High Channel	[
Modulation	RB Size	RB Offset	23025 (700.5 MHz)	23095 (707.5 MHz)	23165 (714.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			(Conducted Power [dBm]		
	1	0	24.32	24.44	24.47		0
	1	7	24.30	24.41	24.51	0	0
	1	14	24.42	24.56	24.40		0
QPSK	8	0	23.37	23.55	23.48	0-1	1
	8	4	23.37	23.56	23.40		1
	8	7	23.34	23.57	23.33		1
	15	0	23.42	23.57	23.46	1 1	1
	1	0	23.54	23.41	23.41		1
	1	7	23.55	23.47	23.46	0-1	1
	1	14	23.65	23.43	23.32	1 1	1
16QAM	8	0	22.32	22.45	22.52		2
	8	4	22.26	22.46	22.44	0-2	2
	8	7	22.14	22.48	22.37	0-2	2
ľ	15	0	22.43	22.54	22.37	1	2

Table 8-4 LTE Band 12 (707.5MHz) Conducted Powers – 3MHz Bandwidth

Table 8-5

LTE Band 12 (707.5MHz) Conducted Powers – 1.4MHz Bandwidth

				LIE Band 12 1.4 MHz Bandwidth			
			Low Channel	Mid Channel	High Channel		
Modulation	RB Size	RB Offset	23017 (699.7 MHz)	23095 (707.5 MHz)	23173 (715.3 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			(Conducted Power [dBm	1]		
	1	0	24.42	24.50	24.27	0	0
	1	2	24.47	24.49	24.40		0
	1	5	24.50	24.52	24.15		0
QPSK	3	0	24.22	24.46	24.41		0
	3	2	24.36	24.57	24.30		0
	3	3	24.38	24.54	24.20		0
	6	0	23.38	23.60	23.34	0-1	1
	1	0	23.60	23.58	23.52		1
	1	2	23.61	23.67	23.47		1
	1	5	23.65	23.60	23.52	0-1	1
16QAM	3	0	23.28	23.34	23.35	J-1	1
	3	2	23.46	23.54	23.39		1
	3	3	23.40	23.31	23.24		1
	6	0	22.58	22.65	22.43	0-2	2

b. LTE Band 5

Table 8-6 LTE Band 5 (836.5MHz) Conducted Powers – 10MHz Bandwidth

			Mid Channel		
Modulation	RB Size	RB Offset	20525 (836.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			Conducted Power [dBm]		
	1	0	24.30		0
	1	25	24.12	0	0
	1	49	24.13		0
QPSK	25	0	23.37		1
	25	12	23.22	0-1	1
	25	25	23.31		1
	50	0	23.27		1
	1	0	23.34		1
	1	25	23.31	0-1	1
	1	49	23.37		1
16QAM	25	0	22.28		2
	25	12	22.12	0-2	2
	25	25	22.12	0-2	2
	50	0	22.30		2

Note: Since LTE Band 5 at 10MHz bandwidth does not support 3 non-overlapping channels, conducted power measurements were made only on the middle channel.

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		E Bulla	0 (000.000.12)			2 Bunawiath	
				LTE Band 5 (Cell) 5 MHz Bandwidth			
			Low Channel	Mid Channel	High Channel		
Modulation	RB Size	RB Offset	20425 (826.5 MHz)	20525 (836.5 MHz)	20625 (846.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
				Conducted Power [dBm]		
	1	0	24.14	24.25	24.31		0
	1	12	24.24	24.31	24.37	0	0
QPSK	1	24	24.22	24.19	24.26		0
	12	0	23.29	23.20	23.28	0-1	1
	12	6	23.35	23.09	23.20		1
	12	13	23.48	23.06	23.26		1
	25	0	23.36	23.16	23.23		1
	1	0	23.32	23.27	23.23		1
	1	12	23.33	23.38	23.03	0-1	1
	1	24	23.14	23.10	23.11	1 1	1
16QAM	12	0	22.20	22.36	22.11		2
	12	6	22.44	22.26	22.14	0.2	2
	12	13	22.33	22.32	22.21	0-2	2
ľ	25	0	22.20	22.33	22.26	1 1	2

Table 8-7 LTE Band 5 (836.5MHz) Conducted Powers – 5MHz Bandwidth

Table 8-8 LTE Band 5 (836.5MHz) Conducted Powers – 3MHz Bandwidth

		r – – – – –	Law Channel	3 MHz Bandwidth	Link Channel	<u>г</u> г	
Modulation	RB Size	RB Offset	Low Channel 20415 (825.5 MHz)	Mid Channel 20525 (836.5 MHz)	High Channel 20635 (847.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			(Conducted Power [dBm	1]		
	1	0	24.27	24.22	24.18		0
	1	7	24.33	24.00	24.11	0	0
QPSK	1	14	24.35	24.05	24.02	1 [0
	8	0	23.30	23.09	23.32		1
	8	4	23.30	23.07	23.28	0-1	1
	8	7	23.35	23.10	23.24	0-1	1
	15	0	23.25	23.11	23.30		1
	1	0	23.33	23.38	23.43		1
	1	7	23.39	23.31	23.34	0-1	1
	1	14	23.37	23.24	23.39	1 1	1
16QAM	8	0	22.39	22.33	22.35		2
	8	4	22.28	22.32	22.44	0-2	2
	8	7	22.24	22.27	22.42	0-2	2
	15	0	22.35	22.22	22.31		2

Table 8-9 LTE Band 5 (836.5MHz) Conducted Powers – 1.4MHz Bandwidth

				LTE Band 5 (Cell) 1.4 MHz Bandwidth			
			Low Channel	Mid Channel	High Channel	_	
Modulation	RB Size	RB Offset	20407 (824.7 MHz)	20525 (836.5 MHz)	20643 (848.3 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
				Conducted Power [dBm]		
	1	0	24.19	24.08	24.14		0
	1	2	24.25	24.29	24.31	0	0
	1	5	24.08	24.09	24.00		0
QPSK	3	0	24.31	24.22	24.11		0
	3	2	24.27	24.12	24.08		0
	3	3	24.29	24.21	24.01		0
	6	0	23.21	23.19	23.11	0-1	1
	1	0	22.92	23.00	23.03		1
	1	2	22.98	23.35	23.29		1
	1	5	22.93	23.41	23.14	0.4	1
16QAM	3	0	23.21	23.24	22.96	0-1	1
	3	2	23.23	23.12	23.05		1
	3	3	23.18	23.26	22.91		1
	6	0	22.35	22.24	22.20	0-2	2

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c. LTE Band 4

			LTE Band 4 (AWS) 20 MHzBandwidth		
			Mid Channel		
Modulation	RB Size	RB Offset	20175 (1732.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			Conducted Power [dBm]		
	1	0	23.04		0
	1	50	22.95	0	0
	1	99	22.98		0
QPSK	50	0	22.15		1
	50	25	22.03	0-1	1
	50	50	22.05	0-1	1
	100	0	22.08		1
	1	0	21.89		1
	1	50	21.93	0-1	1
	1	99	21.74		1
16QAM	50	0	21.07		2
	50	25	20.99	0-2	2
	50	50	21.16	0-2	2
	100	0	21.10	1	2

Table 8-10 LTE Band 4 (1732 5MHz) – 20MHz Bandwidth Justod Dowore

Note: Since LTE Band 4 at 20MHz bandwidth does not support 3 non-overlapping channels, conducted power measurements were made only on the middle channel.

-	Table 8-11
LTE Band 4 (1732.5MHz) Co	nducted Powers – 15MHz Bandwidth

				LTE Band 4 (AWS) 15 MHzBandwidth			
			Low Channel	Mid Channel	High Channel		
Modulation	RB Size	RB Offset	20025 (1717.5 MHz)	20175 (1732.5 MHz)	20325 (1747.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			C	Conducted Power [dBm	i]		
	1	0	22.94	23.06	23.10		0
	1	36	23.01	22.98	22.98	0	0
	1	74	22.85	23.01	23.07		0
QPSK	36	0	22.11	21.97	21.96		1
	36	18	22.10	21.95	21.78	0-1	1
	36	37	22.13	22.10	21.84	0-1	1
	75	0	22.07	22.15	21.87		1
	1	0	22.15	22.06	22.09		1
	1	36	22.05	21.95	22.14	0-1	1
	1	74	22.13	22.12	22.10		1
16QAM	36	0	21.08	20.98	20.99		2
	36	18	21.14	20.95	20.82	0-2	2
	36	37	21.12	21.10	20.74	0-2	2
	75	0	21.13	21.07	21.00	1	2

Table 8-12 LTE Band 4 (1732.5MHz) Conducted Powers – 10MHz Bandwidth

				LTE Band 4 (AWS) 10 MHzBandwidth			
			Low Channel	Mid Channel	High Channel		
Modulation	RB Size	RB Offset	20000 (1715.0 MHz)	20175 (1732.5 MHz)	20350 (1750.0 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			0	Conducted Power [dBm]		
	1	0	23.08	23.03	23.08		0
	1	25	22.89	23.10	23.07	0	0
	1	49	22.94	23.06	22.97		0
QPSK	25	0	22.16	21.98	21.79		1
	25	12	22.06	22.00	21.88	0-1	1
	25	25	22.17	21.95	21.88	0-1	1
	50	0	22.13	22.01	21.93		1
	1	0	22.09	21.88	22.08		1
	1	25	22.01	21.71	21.89	0-1	1
	1	49	22.13	22.15	22.13		1
16QAM	25	0	21.02	21.02	20.91		2
	25	12	21.11	21.07	21.06	0-2	2
	25	25	21.02	20.99	20.97	0-2	2
	50	0	21.10	20.91	21.00		2
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Portable Handset

	LII	E Dallu 4	(1732.310112)	Conducted P		Z Danuwiutii	
				LTE Band 4 (AWS)			
		· · · · ·		5 MHzBandwidth		r	
			Low Channel	Mid Channel	High Channel		
Modulation	RB Size	RB Offset	19975 (1712.5 MHz)	20175 (1732.5 MHz)	20375 (1752.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			(Conducted Power [dBm	1]		
	1	0	22.80	22.74	22.64		0
	1	12	23.05	22.94	22.68	0	0
	1	24	22.67	22.80	22.73		0
QPSK	12	0	22.09	22.01	21.97		1
	12	6	22.05	21.94	21.93	0-1	1
	12	13	22.05	21.97	21.91	0-1	1
	25	0	22.03	21.98	21.98		1
	1	0	21.92	21.79	21.72		1
	1	12	22.00	21.91	21.60	0-1	1
	1	24	21.93	21.74	21.81		1
16QAM	12	0	21.07	20.89	21.04		2
	12	6	21.10	20.82	20.92	0-2	2
	12	13	21.14	20.87	20.91	0-2	2
	25	0	20.95	21.02	21.04	1 1	2

Table 8-13 I TE Band 4 (1732 5MHz) Conducted Powers – 5MHz Bandwidth

Table 8-14 LTE Band 4 (1732.5MHz) Conducted Powers – 3MHz Bandwidth

			Low Channel	Mid Channel	High Channel		
Modulation	RB Size	RB Offset	19965 (1711.5 MHz)	20175 (1732.5 MHz)	20385 (1753.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
				Conducted Power [dBm	1]		
	1	0	23.01	22.91	22.98		0
	1	7	22.95	22.83	23.00	0	0
	1	14	22.87	22.88	23.05		0
QPSK	8	0	22.03	22.01	22.02		1
	8	4	22.05	22.01	21.97	0-1	1
	8	7	22.01	22.03	22.01	0-1	1
	15	0	22.12	22.02	22.00		1
	1	0	22.02	22.05	21.58		1
	1	7	22.14	21.97	21.77	0-1	1
	1	14	22.00	21.92	21.57		1
16QAM	8	0	21.04	21.10	21.05		2
	8	4	20.99	21.09	21.02	0-2	2
	8	7	21.04	21.08	21.11	0-2	2
	15	0	20.96	21.05	20.96	1 1	2

Table 8-15 LTE Band 4 (1732.5MHz) Conducted Powers - 1.4MHz Bandwidth

				LTE Band 4 (AWS) 1.4 MHzBandwidth			
			Low Channel	Mid Channel	High Channel		
Modulation	RB Size	RB Offset	19957 (1710.7 MHz)	20175 (1732.5 MHz)	20393 (1754.3 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			(Conducted Power [dBm	1]		
	1	0	22.94	22.95	22.97		0
	1	2	22.96	23.12	23.11	0	0
	1	5	22.62	22.86	22.84		0
QPSK	3	0	22.94	22.94	23.02		0
	3	2	23.00	23.01	23.14		0
	3	3	22.89	22.95	23.03		0
	6	0	21.90	21.98	21.98	0-1	1
	1	0	21.63	21.78	21.40		1
	1	2	21.75	21.95	22.03	1	1
	1	5	21.54	21.66	21.71	0-1	1
16QAM	3	0	21.90	21.80	21.87	0-1	1
	3	2	22.10	21.98	21.91]	1
	3	3	22.12	22.13	21.77	1	1
	6	0	21.01	21.07	20.89	0-2	2

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d. LTE Band 2

			(1000.010112)		5 wers = 20 with	12 Balluwiuth	
				LTE Band 2 (PCS)			
20 MHz Bandwidth							
			Low Channel	Mid Channel	High Channel		
Modulation	RB Size	RB Offset	18700 (1860.0 MHz)	18900 (1880.0 MHz)	19100 (1900.0 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			(Conducted Power [dBm	1]		
	1	0	23.11	23.09	23.04		0
	1	50	23.18	22.96	22.89	0	0
	1	99	23.08	23.17	22.89		0
QPSK	50	0	21.97	21.93	21.86		1
	50	25	21.99	21.83	21.78	0-1	1
	50	50	22.18	22.05	21.83		1
	100	0	22.09	21.87	21.85		1
	1	0	21.51	21.77	21.58		1
	1	50	21.74	21.89	21.71	0-1	1
	1	99	21.76	21.58	21.48	1	1
16QAM	50	0	20.88	20.80	20.86		2
	50	25	20.82	20.75	20.72	0-2	2
	50	50	20.87	20.96	20.78	0-2	2
ľ	100	0	20.90	20.76	20.78	1 [2

Table 8-16 LTE Band 2 (1880.0MHz) Conducted Powers – 20MHz Bandwidth

Table 8-17 LTE Band 2 (1880.0MHz) Conducted Powers – 15MHz Bandwidth

				LTE Band 2 (PCS) 15 MHz Bandwidth			
			Low Channel	Mid Channel	High Channel		
Modulation	RB Size	RB Offset	18675 (1857.5 MHz)	18900 (1880.0 MHz)	19125 (1902.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			(Conducted Power [dBm]		
	1	0	22.91	22.95	23.00		0
	1	36	22.78	22.77	22.84	0	0
	1	74	22.99	22.97	22.84		0
QPSK	36	0	21.94	22.10	21.65		1
	36	18	21.91	21.85	21.65	0-1	1
	36	37	22.05	22.04	21.89		1
	75	0	21.96	22.00	21.84		1
	1	0	21.68	21.88	21.80		1
	1	36	21.60	21.84	21.84	0-1	1
	1	74	21.76	21.73	22.15		1
16QAM	36	0	20.93	20.91	20.78		2
	36	18	20.92	20.89	20.60	0-2	2
	36	37	20.91	21.00	20.77	0-2	2
	75	0	20.81	20.93	20.82	1	2

Table 8-18

LTE Band 2 (1880.0MHz) Conducted Powers – 10MHz Bandwidth

			Low Channel	Mid Channel	High Channel		
Modulation	RB Size	RB Offset	18650 (1855.0 MHz)	18900 (1880.0 MHz)	19150 (1905.0 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB
				Conducted Power [dBm]		
	1	0	22.88	23.02	22.58		0
	1	25	22.98	23.05	23.10	0	0
	1	49	22.75	22.96	22.98		0
QPSK	25	0	22.02	21.79	21.87		1
	25	12	21.96	21.83	21.95	0-1	1
	25	25	21.92	21.91	21.87	0-1	1
	50	0	21.91	21.80	21.83		1
	1	0	21.82	21.81	21.80		1
	1	25	21.48	21.90	22.15	0-1	1
	1	49	22.07	21.74	22.07		1
16QAM	25	0	21.10	20.81	21.13		2
	25	12	20.92	20.76	21.00	0-2	2
	25	25	20.90	20.73	20.86	0-2	2
	50	0	20.95	20.70	20.84	1	2
		PC1	EST	AC (RF EMISSIONS		LG	Approve

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	Table 8-19
LTE Band 2 (1880.0MHz) Conducted Powers – 5MHz Bandwidth

			(10001011112)	Oonducted I		2 Ballamath	
				LTE Band 2 (PCS)			
				5 MHz Bandwidth			
			Low Channel	Mid Channel	High Channel		
Modulation	RB Size	RB Offset	18625 (1852.5 MHz)	18900 (1880.0 MHz)	19175 (1907.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			(Conducted Power [dBm	1]		
	1	0	22.81	22.83	22.92		0
	1	12	22.73	22.84	23.14	0	0
	1	24	22.74	23.04	22.68		0
QPSK	12	0	21.89	21.82	21.98		1
	12	6	21.89	21.81	22.00	0-1	1
	12	13	21.86	21.75	21.86	0-1	1
	25	0	21.80	21.69	21.98		1
	1	0	21.59	21.73	21.57		1
	1	12	21.42	21.93	21.96	0-1	1
	1	24	21.55	21.65	21.51		1
16QAM	12	0	20.56	20.64	20.73		2
	12	6	20.74	20.63	20.78	0-2	2
	12	13	20.72	20.79	20.68	0-2	2
	25	0	20.63	20.73	20.79	1 1	2

Table 8-20 LTE Band 2 (1880.0MHz) Conducted Powers – 3MHz Bandwidth

				LTE Band 2 (PCS) 3 MHz Bandwidth			
			Low Channel	Mid Channel	High Channel		
Modulation	RB Size	RB Offset	18615 (1851.5 MHz)	18900 (1880.0 MHz)	19185 (1908.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			(Conducted Power [dBm]		
	1	0	22.63	22.94	22.87		0
	1	7	22.76	22.95	22.91	0	0
	1	14	22.87	22.83	22.79		0
QPSK	8	0	21.82	21.79	21.98		1
	8	4	21.87	21.72	21.88	0-1	1
	8	7	21.91	21.76	21.91	0-1	1
	15	0	21.87	21.74	22.01		1
	1	0	21.81	21.85	22.03		1
	1	7	21.90	21.74	22.17	0-1	1
	1	14	21.73	21.57	22.02		1
16QAM	8	0	20.77	20.85	20.98		2
	8	4	20.73	20.90	20.95	0-2	2
	8	7	20.77	20.72	20.88	0-2	2
	15	0	20.74	20.64	20.85	1	2

Table 8-21 LTE Band 2 (1880.0MHz) Conducted Powers – 1.4MHz Bandwidth

				LTE Band 2 (PCS) 1.4 MHz Bandwidth			
			Low Channel	Mid Channel	High Channel		
Modulation	RB Size	RB Offset	18607 (1850.7 MHz)	18900 (1880.0 MHz)	19193 (1909.3 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
	1	0	22.99	22.70	22.73		0
	1	2	22.80	22.77	22.78	0	0
	1	5	22.89	22.76	22.83		0
QPSK	3	0	22.89	22.74	22.98		0
	3	2	22.86	22.89	23.08		0
	3	3	22.82	22.87	22.95		0
	6	0	21.99	21.81	21.92	0-1	1
	1	0	21.97	21.47	22.16		1
	1	2	22.05	21.61	22.08		1
	1	5	22.00	21.65	21.95	0-1	1
16QAM	3	0	21.95	21.67	22.17	0-1	1
	3	2	21.91	21.55	22.12	1	1
	3	3	21.87	21.41	22.02	1	1
	6	0	20.74	20.41	20.81	0-2	2

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VII. WLAN Conducted Powers

			Hz, SISO) Average RF Power 2.4GHz Conducted Power [dBm]				
Freq [MHz]	Channel	IEEE Transmission Mode					
		802.11b	802.11g	802.11n			
2412	1	15.67	13.35	12.40			
2417	2	15.69	13.75	12.80			
2437	6	16.20	14.10	13.18			
2457	10	15.70	13.70	12.65			
2462	11	15.77	10.51	9.80			

Table 8-22

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9. JUSTIFICATION OF HELD TO EAR MODES TESTED

I. Analysis of RF Air Interface Technologies

- **a.** According to the April 2013 TCB workshop slides, OTT data services are outside the current definition of a managed CMRS service and are currently not required to be evaluated.
- b. No associated T-coil measurements for VoLTE or VoIP over WIFI CMRS have been made in accordance with the guidance issued by OET in KDB publication 285076 D02 T-Coil testing for CMRS IP.
- c. An analysis was performed, following the guidance of §4.3 and §4.4 of the ANSI standard, of the RF air interface technologies being evaluated. The factors that will affect the RF interference potential were evaluated, and the worst case operating modes were identified and used in the evaluation. A WD's interference potential is a function both of the WD's average near-field field strength and of the signal's audio-frequency amplitude modulation characteristics. Per §4.4, RF air interface technologies that have low power have been found to produce sufficiently low RF interference potential, so it is possible to exempt them from the product testing specified in Clause 5 of the ANSI standard. An RF air interface technology of a device is exempt from testing when its average antenna input power plus its MIF is ≤17dBm for all of its operating modes. RF air interface technologies exempted from testing in this manner are automatically assigned an M4 rating to be used in determining the overall rating for the WD.

The worst case MIF plus the worst case average antenna input power for all modes are investigated below to determine the testing requirements for this device.

Table 9-1

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Max Power + MIF calculations for Low Power Exemptions						
Air Interface	Maximum Average Power (dBm)	Worst Case MIF (dB)	Total (Power + MIF, dB)	C63.19 Testing Required		
GSM850	24.40*	3.53	27.93	Yes		
GSM1900	20.64*	3.54	24.18	Yes		
UMTS - RMC	23.08	-23.87	-0.79	No		
UMTS - AMR	23.10	-12.86	10.24	No		
LTE - FDD	24.64	-9.43	15.21	No		
2.4GHz WLAN	16.20	-11.68	4.52	No		

II. Individual Mode Evaluations

* Note: ANSI C63.19-2011 Sec. 4.4 Footnote 20 indicates the use of a long averaging time for measuring the antenna input power when using this method of exclusion. Therefore, the frame averaged power was calculated for these modes in this investigation.

III. Low-Power Exemption Conclusions

Per ANSI C63.19-2011, RF Emissions testing for this device is required only for GSM voice modes. All other air interfaces are exempt.

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10. OVERALL MEASUREMENT SUMMARY

FCC ID:	ZNFAS110
S/N:	02065

I. E-FIELD EMISSIONS:

				HAC Da	ata Sum	mary for	E-field				
Mode	Channel	Scan Center	Conducted Power at BS (dBm)	Time Avg. Field (V/m)	Time Avg. Field [dB(V/m)]	MIF (dB)	Audio Interference Level [dB(V/m)]	FCC Limit (dBV/m)	FCC Margin (dB)	Result	Excl Blocks per 5.5
E-Field Emissi	ons										
	128	Acoustic	33.43	51.12	34.17	3.53	37.70	45.00	-7.30	M4	none
GSM850	190	Acoustic	33.27	53.00	34.49	3.53	38.02	45.00	-6.98	M4	none
	251	Acoustic	33.35	57.76	35.23	3.53	38.76	45.00	-6.24	M4	none
	512	Acoustic	29.67	29.35	29.35	3.54	32.89	35.00	-2.11	M3	none
GSM1900	661	Acoustic	29.53	29.26	29.33	3.53	32.86	35.00	-2.14	M3	none
G3W1900	810	Acoustic	29.58	25.58	28.16	3.54	31.70	35.00	-3.30	M3	none
	512	T-Coil	29.67	27.89	28.91	3.54	32.45	35.00	-2.55	M3	none

Table 10-1

Figure 10-1 Sample E-field Scan Overlay (See Test Setup Photographs for actual WD overlay)

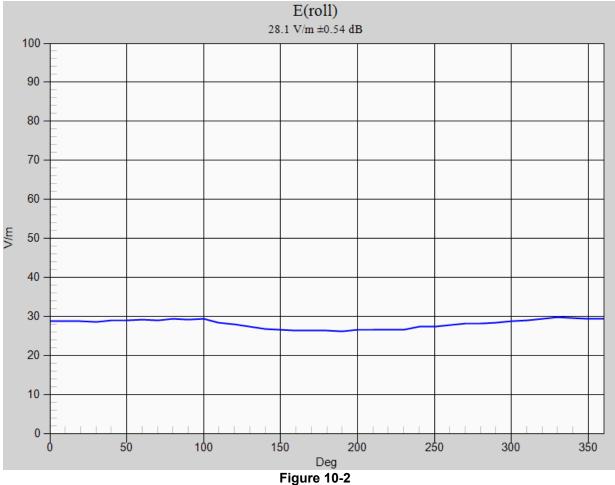
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II. Worst-case Configuration Evaluation

	Peak Reading 360° Probe Rotation at Azimuth axis									
Mode	Channel	Scan Center	Time Avg. Field (V/m)	Time Avg. Field [dB(V/m)]	MIF (dB)	Audio Interference Level [dB(V/m)]	FCC Limit (dBV/m)	FCC Margin (dB)	Result	Excl Blocks per 5.5
Probe Rotation	Probe Rotation at Worst-Case									
GSM1900	512	Acoustic	29.67	29.45	3.54	32.99	35.00	-2.01	M3	none

Table 10-2



Worst-Case Probe Rotation about Azimuth axis

* Note: Locations of probe rotation (with and without exclusions) are shown in Figure 10-1 denoted by the green square markers.

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11. EQUIPMENT LIST

Equipment List Manufacturer Cal Date Cal Interval Cal Due Serial Number Model Description MY42082659 Agilent E4438C ESG Vector Signal Generator 3/13/2015 Biennial 3/13/2017 E4432B 3/5/2016 3/5/2017 US40053896 Agilent ESG-D Series Signal Generator Annual N5182A MXG Vector Signal Generator 3/5/2016 3/5/2017 MY47420800 Agilent Annual Amplifier Research CBT* 433978 15S1G6 Amplifier N/A N/A Anritsu ML2496A Power Meter 3/5/2016 Annual 3/5/2017 1351001 Anritsu MA2481A Power Sensor 3/3/2016 Annual 3/3/2017 5318 Anritsu MA2481A **Power Sensor** 3/3/2016 Annual 3/3/2017 2400 Anritsu MA2411B Pulse Power Sensor 8/18/2016 Annual 8/18/2017 1126066 Anritsu MA2411B Pulse Power Sensor 8/18/2016 Annual 8/18/2017 1207470 6/2/2016 MA24106A USB Power Sensor 6/2/2017 1244512 Anritsu Annual MA24106A **USB** Power Sensor 6/2/2016 6/2/2017 1248508 Anritsu Annual NLP-1200+ Low Pass Filter DC to 1000 MHz CBT* Mini-Circuits N/A N/A N/A Mini-Circuits NLP-2950+ Low Pass Filter DC to 2700 MHz N/A CBT* N/A N/A N/A CBT* N/A Mini-Circuits BW-N20W5 1226 **Power Attenuator** Pasternack PE2237-20 **Bidirectional Coupler** N/A CBT* N/A N/A Pasternack NC-100 **Torque Wrench** 11/6/2015 Biennial 11/6/2017 N/A 108843 Rohde & Schwarz CMW500 Radio Communication Tester 6/3/2016 Annual 6/3/2017 SPEAG AIA Audio Interference Analzyer N/A CBT* N/A 1010 SPEAG CD1880V3 Freespace 1880 MHz Dipole 5/12/2016 5/12/2018 1064 Biennial SPEAG Freespace 835 MHz Dipole CD835V3 5/10/2016 Biennial 5/10/2018 1082 SPEAG ER3DV6 E-field Probe 8/22/2016 Annual 8/22/2017 2335 SPEAG DAE4 **Dasy Data Acquisition Electronics** 9/15/2016 9/15/2017 1333 Annual

Table 11-1

Calibration traceable to the National Institute of Standards and Technology (NIST).

*Note: CBT (Calibrated Before Testing). Prior to testing, the measurement paths containing a cable, attenuator, coupler or filter were connected to a calibrated source (i.e. a signal generator) to determine the losses of the measurement path. The power meter offset was then adjusted to compensate for the measurement system losses. This level offset is stored within the power meter before measurements are made. This calibration verification procedure applies to the system verification and output power measurements. The calibrated reading is then taken directly from the power meter after compensation of the losses for all final power measurements.

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12. MEASUREMENT UNCERTAINTY

Table 12-1

Uncertainty Estimation Table

	Wireless Communications Device Near-Field Measurement Uncertainty Estimation							
Uncertainty Component	Data (dB)	Data Type	Prob. Dist.	Divisor	Ci (E)	Unc. (dB)	Notes/Comments	
Measurement System	-					4		
RF System Reflections	0.50	Tolerance	Ν	1.00	1	0.50	* Refl. < -20 dB	
Field Probe Calibration	0.21	Tolerance	Ν	1.00	1	0.21		
Field Probe Isotropy	0.01	Tolerance	Ν	1.00	1	0.01		
Field Probe Frequency Response	0.135	Tolerance	Ν	1.00	1	0.14		
Field Probe Linearity	0.013	Tolerance	Ν	1.00	1	0.01		
Modulation Interference Factor	0.20	Tolerance	R	1.73	1	0.12	Applicable for M-rating testing	
Boundary Effects	0.105	Accuracy	R	1.73	1	0.06	*	
Probe Positioning Accuracy	0.20	Accuracy	R	1.73	1	0.12	*	
Probe Positioner	0.050	Accuracy	R	1.73	1	0.03	*	
Extrapolation/Interpolation	0.045	Tolerance	R	1.73	1	0.03	*	
Resolution to 2mm error	0.21	Tolerance	Ν	1.00	1	0.21		
System Detection Limit	0.05	Tolerance	R	1.73	1	0.03	*	
Readout Electronics	0.015	Tolerance	Ν	1.00	1	0.02	*	
Integration Time	0.11	Tolerance	R	1.73	1	0.06	*	
Response Time	0.033	Tolerance	R	1.73	1	0.02	*	
Phantom Thickness	0.10	Tolerance	R	1.73	1	0.06	*	
System Repeatability (Field x 2=power)	0.17	Tolerance	Ν	1.00	1	0.17	*	
Test Sample Related						•		
Device Positioning Vertical	0.2	Tolerance	R	1.73	1	0.12	*	
Device Positioning Lateral	0.045	Tolerance	R	1.73	1	0.03	*	
Device Holder and Phantom	0.1	Tolerance	R	1.73	1	0.06	*	
Power Drift	0.21	Tolerance	R	1.73	1	0.12		
Combined Standard Uncertainty (k=1)						0.66	16.3%	
Expanded Uncertainty [95% confidence]						1.31	32.6%	
Expanded Uncertainty [95% confidence] on Field						0.66	16.3%	

Notes:

1. Test equipments are calibrated according to techniques outlined in NIS81, NIS3003 and NIST Tech Note 1297. All equipments have traceability according to NIST. Measurement Uncertainties are defined in further detail in NIS 81 and NIST Tech Note 1297 and UKAS M3003.

2. * Uncertainty specifications from Schmidt & Partner Engineering AG (not site specific)

Measurement uncertainty reflects the quality and accuracy of a measured result as compared to the true value. Such statements are generally required when stating results of measurements so that it is clear to the intended audience that the results may differ when reproduced by different facilities. Measurement results vary due to the measurement uncertainty of the instrumentation, measurement technique, and test engineer. Most uncertainties are calculated using the tolerances of the instrumentation used in the measurement, the measurement setup variability, and the technique used in performing the test. While not generally included, the variability of the equipment under test also figures into the overall measurements (so-called Type A uncertainty). This may mean that the Hearing Aid immunity tests may have to be repeated by taking down the test setup and resetting it up so that there are a statistically significant number of repeat measurements to identify the measurement uncertainty. By combining the repeat measurements to identify the measurement uncertainty. By combining the repeat measurements to identify the measurement uncertainty. By and NIS 3003, the overall measurement uncertainty was estimated.

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13. TEST DATA

See following Attached Pages for Test Data.

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Date: 01/23/2017



DUT: CD835V3 - SN1082

Type: CD835V3 Serial: 1082

Communication System: CW; Frequency: 835 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: ER3DV6 SN2335; Calibrated: 08/22/2016
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn1333; Calibrated: 09/15/2016
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.8 (8);

835 MHz / 100mW HAC Dipole Validation at 15mm /Hearing Aid Compatibility Test (41x361x1):



Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 121.5 V/m; Power Drift = -0.08 dB Applied MIF = 0.00 dB Average Value of Peak (interpolated) = 115.8 V/m

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Date: 01/23/2017



DUT: CD1880V3 - SN1064

Type: CD1880V3 Serial: 1064

Communication System: CW; Frequency: 1880 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: ER3DV6 SN2335; Calibrated: 08/22/2016
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn1333; Calibrated: 09/15/2016
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.8 (8);

1880 MHz / 100mW HAC Dipole Validation at 15mm /Hearing Aid Compatibility Test (41x181x1):



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DUT: ZNFAS110

Type: Portable Handset Serial: 02065 Backlight off Duty Cycle: 1:8.3

Communication System: GSM; Frequency: 848.8 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

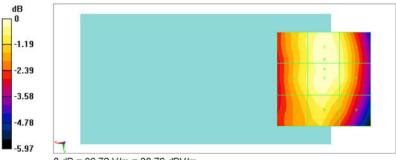
- Probe: ER3DV6 SN2335; Calibrated: 08/22/2016
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1333; Calibrated: 09/15/2016
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.8 (8);

GSM850 High Channel/Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 72.94 V/m; Power Drift = 0.04 dB Applied MIF = 3.53 dB RF audio interference level = 38.76 dBV/m **Emission category: M4**

MIF scaled E-field

Grid 1 M4	Grid 2 M4	Grid 3 M4
38.08 dBV/m	38.76 dBV/m	38.29 dBV/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
38.08 dBV/m	38.75 dBV/m	38.32 dBV/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
37.77 dBV/m	38.32 dBV/m	37.6 dBV/m



0 dB = 86.72 V/m = 38.76 dBV/m

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DUT: ZNFAS110

Type: Portable Handset Serial: 02065 Backlight off Duty Cycle: 1:8.3

Communication System: GSM; Frequency: 1850.2 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: ER3DV6 SN2335; Calibrated: 08/22/2016
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1333; Calibrated: 09/15/2016
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.8 (8);

GSM1900 Low Channel/Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 27.48 V/m; Power Drift = -0.17 dB Applied MIF = 3.54 dB RF audio interference level = 32.89 dBV/m **Emission category: M3**

MIF scaled E-field

Grid 1 M3	Grid 2 M3	Grid 3 M3
30.76 dBV/m	32.12 dBV/m	31.45 dBV/m
Grid 4 M4	Grid 5 M3	Grid 6 M3
28.12 dBV/m	31.49 dBV/m	31.43 dBV/m
Grid 7 M3	Grid 8 M3	Grid 9 M3
31.04 dBV/m	32.89 dBV/m	32.82 dBV/m



0 dB = 44.12 V/m = 32.89 dBV/m

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14. CALIBRATION CERTIFICATES

The following pages include the probe calibration used to evaluate HAC for the DUT.

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Engineering AG Zoughausstrasse 43, 8004 Zurich, Switzerland



Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Client PC Test

Certificate No: ER3-2335_Aug16

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Object	ER3DV6 - SN:233	5	
Calibration procedure(s)	QA CAL-02.v8, QA Calibration procedu evaluations in air	CAL-25.v6 ure for E-field probes optimized f	or close near field
Calibration date:	August 22, 2016		
The measurements and the un	certainties with confidence prot	al standards, which realize the physical units bability are given on the following pages and a facility: environment temperature (22 ± 3)°C a	are part of the certificate.
Primary Standards		Cal Date (Certificate No.)	Scheduled Calibration
Primary Standards	ID SN: 104778	Cal Date (Certificate No.)	Scheduled Calibration
Power meter NRP	SN: 104778	06-Apr-16 (No. 217-02288/02289)	Арг-17
Power meter NRP Power sensor NRP-Z91	SN: 104778 SN: 103244	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288)	Apr-17 Apr-17
Power meter NRP Power sensor NRP-Z91 Power sensor NRP-Z91	SN: 104778	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289)	Apr-17 Apr-17 Apr-17
Power meter NRP Power sensor NRP-291 Power sensor NRP-291 Reference 20 dB Attenuator	SN: 104778 SN: 103244 SN: 103245	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289) 06-Apr-16 (No. 217-02289) 05-Apr-16 (No. 217-02293)	Apr-17 Apr-17
	SN: 104778 SN: 103244 SN: 103245 SN: S5277 (20x)	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289)	Apr-17 Apr-17 Apr-17 Apr-17 Apr-17
Power meter NRP Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Reference Probe ER3DV6	SN: 104778 SN: 103244 SN: 103245 SN: S5277 (20x) SN: 2328	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289) 05-Apr-16 (No. 217-02293) 12-Oct-15 (No. ER3-2328_Oct15)	Apr-17 Apr-17 Apr-17 Apr-17 Oct-16
Power meter NRP Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Reference Probe ER3DV6	SN: 104778 SN: 103244 SN: 103245 SN: S5277 (20x) SN: 2328	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289) 05-Apr-16 (No. 217-02293) 12-Oct-15 (No. ER3-2328_Oct15)	Apr-17 Apr-17 Apr-17 Apr-17 Oct-16
Power meter NRP Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Reference Probe ER3DV6 DAE4	SN: 104778 SN: 103244 SN: 103245 SN: 55277 (20x) SN: 2328 SN: 789	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289) 05-Apr-16 (No. 217-02293) 12-Oct-15 (No. ER3-2328_Oct15) 31-Mar-16 (No. DAE4-789_Mar16)	Apr-17 Apr-17 Apr-17 Apr-17 Oct-16 Mar-17
Power meter NRP Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Reference Probe ER3DV6 DAE4 Secondary Standards	SN: 104778 SN: 103244 SN: 103245 SN: 55277 (20x) SN: 2328 SN: 789 ID	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289) 05-Apr-16 (No. 217-02289) 12-Oct-15 (No. ER3-2328_Oct15) 31-Mar-16 (No. DAE4-789_Mar16) Check Date (in house)	Apr-17 Apr-17 Apr-17 Apr-17 Oct-16 Mar-17 Scheduled Check
Power meter NRP Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Reference Probe ER3DV6 DAE4 Secondary Standards Power meter E4419B	SN: 104778 SN: 103244 SN: 103245 SN: 55277 (20x) SN: 2328 SN: 789 ID SN: GB41293874	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 05-Apr-16 (No. 217-02289) 05-Apr-16 (No. 217-02293) 12-Oct-15 (No. ER3-2328_Oct15) 31-Mar-16 (No. DAE4-789_Mar16) Check Date (in house) 06-Apr-16 (in house check Jun-16)	Apr-17 Apr-17 Apr-17 Apr-17 Oct-16 Mar-17 Scheduled Check In house check: Jun-18
Power meter NRP Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Reference Probe ER3DV6 DAE4 Secondary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A RF generator HP 8648C	SN: 104778 SN: 103244 SN: 103245 SN: 55277 (20x) SN: 2328 SN: 789 ID SN: GB41293874 SN: MY41498087	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289) 05-Apr-16 (No. 217-02289) 12-Oct-15 (No. ER3-2328_Oct15) 31-Mar-16 (No. DAE4-789_Mar16) Check Date (in house) 06-Apr-16 (in house check Jun-16) 06-Apr-16 (in house check Jun-16)	Apr-17 Apr-17 Apr-17 Apr-17 Oct-16 Mar-17 Scheduled Check In house check: Jun-18 In house check: Jun-18
Power meter NRP Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Reference Probe ER3DV6 DAE4 Secondary Standards Power meter E4419B Power sensor E4412A	SN: 104778 SN: 103244 SN: 103245 SN: 55277 (20x) SN: 2328 SN: 789 ID SN: 6B41293874 SN: WY41498087 SN: 000110210	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289) 05-Apr-16 (No. 217-02293) 12-Oct-15 (No. ER3-2328, Oct15) 31-Mar-16 (No. DAE4-789_Mar16) Check Date (in house) 06-Apr-16 (in house check Jun-16) 06-Apr-16 (in house check Jun-16)	Apr-17 Apr-17 Apr-17 Apr-17 Oct-16 Mar-17 Scheduled Check In house check: Jun-18 In house check: Jun-18 In house check: Jun-18
Power meter NRP Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Reference Probe ER3DV6 DAE4 Secondary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A RF generator HP 8648C	SN: 104778 SN: 103244 SN: 103245 SN: 55277 (20x) SN: 2328 SN: 789 ID SN: GB41293874 SN: 000110210 SN: US3642U01700 SN: US37390585	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289) 05-Apr-16 (No. 217-02293) 12-Oct-15 (No. ER3-2328 Oct15) 31-Mar-16 (No. DAE4-789_Mar16) 	Apr-17 Apr-17 Apr-17 Oct-16 Mar-17 Scheduled Check In house check: Jun-18 In house check: Jun-18
Power meter NRP Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Reference Probe ER3DV6 DAE4 Secondary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A RF generator HP 8648C	SN: 104778 SN: 103244 SN: 103245 SN: 55277 (20x) SN: 2328 SN: 789 ID SN: GB41293874 SN: MY41498087 SN: 000110210 SN: US3642U01700	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 05-Apr-16 (No. 217-02289) 05-Apr-16 (No. 217-02293) 12-Oct-15 (No. ER3-2328_Oct15) 31-Mar-16 (No. DAE4-789_Mar16) Check Date (in house) 06-Apr-16 (in house check Jun-16) 06-Apr-16 (in house check Jun-16) 06-Apr-16 (in house check Jun-16)	Apr-17 Apr-17 Apr-17 Apr-17 Oct-16 Mar-17 Scheduled Check In house check: Jun-18 In house check: Jun-18 In house check: Jun-18 In house check: Jun-18

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Accreditation No.: SCS 0108

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Glossary:

NORMx,y,z DCP CF A, B, C, D Polarization @ Polarization &

sensitivity in free space diode compression point crest factor (1/duty_cycle) of the RF signal modulation dependent linearization parameters $\boldsymbol{\phi}$ rotation around probe axis 9 rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., 9 = 0 is normal to probe axis information used in DASY system to align probe sensor X to the robot coordinate system

Connector Angle

Calibration is Performed According to the Following Standards:

- IEEE Std 1309-2005, " IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005 a)
- b) CTIA Test Plan for Hearing Aid Compatibility, Rev 3.0, November 2013

Methods Applied and Interpretation of Parameters:

- NORMx, y, z: Assessed for E-field polarization $\vartheta = 0$ for XY sensors and $\vartheta = 90$ for Z sensor (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide).
- NORM(f)x,y,z = NORMx,y,z * frequency_response (see Frequency Response Chart).
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- PAR: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- Ax,y,z; Bx,y,z; Cx,y,z; Dx,y,z; VRx,y,z: A, B, C, D are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. *VR* is the maximum calibration range expressed in RMS voltage across the diode.
- Spherical isotropy (3D deviation from isotropy): in a locally homogeneous field realized using an open wavequide setup
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the NORMx (no uncertainty required).

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Probe ER3DV6

SN:2335

Manufactured: Calibrated:

September 9, 2003 August 22, 2016

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Calibrated for DASY/EASY Systems (Note: non-compatible with DASY2 system!)

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ER3DV6 - SN:2335

DASY/EASY - Parameters of Probe: ER3DV6 - SN:2335

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm $(\mu V/(V/m)^2)$	1.60	1.62	1.80	± 10.1 %
DCP (mV) ⁸	99.1	100.1	101.0	

Modulation Calibration Parameters

UID	Communication System Name		A dB	Β dB√μV	С	D dB	VR mV	Unc ^E (k=2)
0	CW	X	0.0	0.0	1.0	0.00	149.7	±3.0 %
		Y	0.0	0.0	1.0		159.7	
		Z	0.0	0.0	1.0		194.8	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^B Numerical linearization parameter: uncertainty not required.
^E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

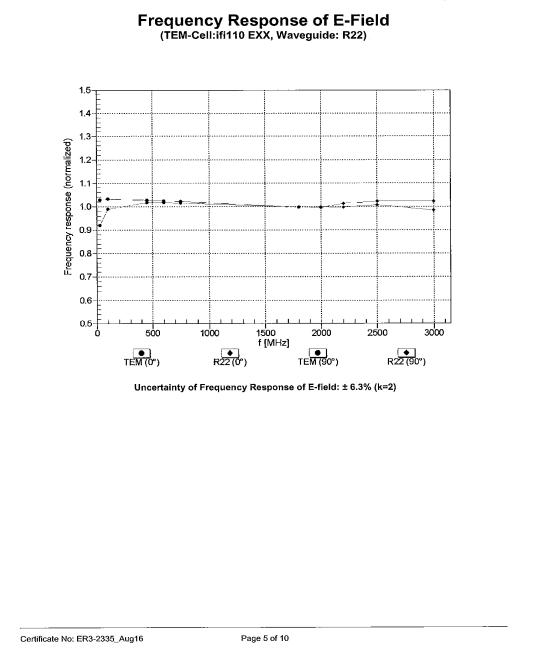
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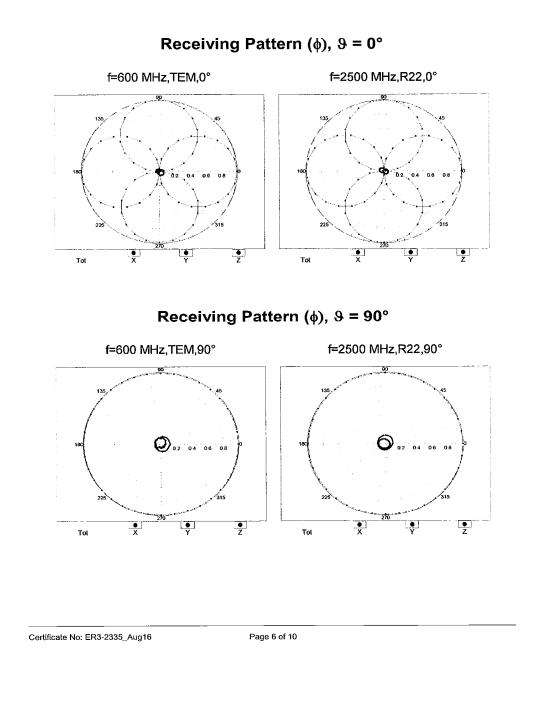
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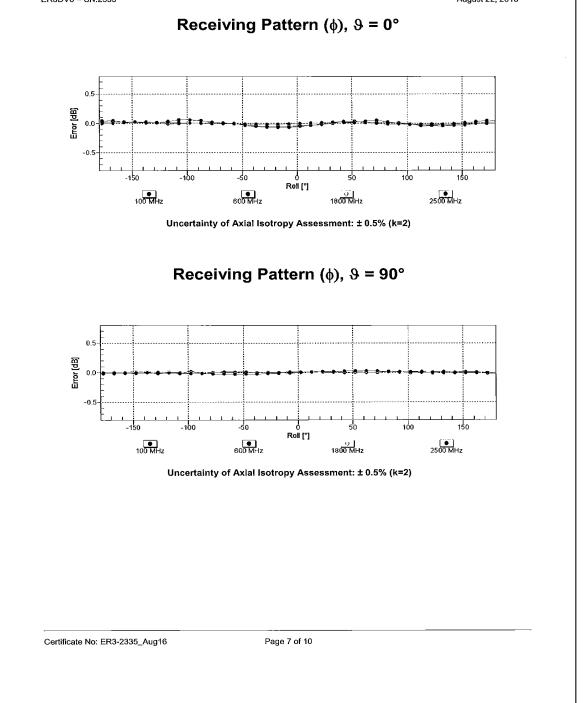


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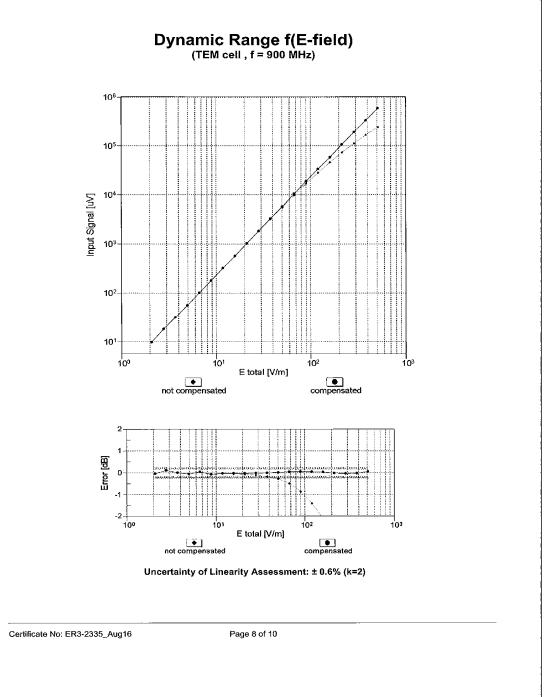
ER3DV6 - SN:2335

August 22, 2016



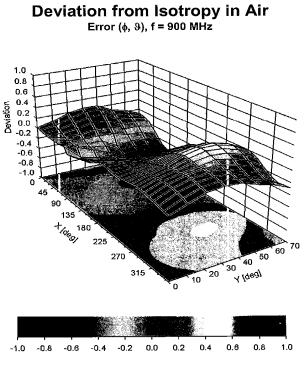
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ER3DV6 -- SN:2335



Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)

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ER3DV6 - SN:2335

DASY/EASY - Parameters of Probe: ER3DV6 - SN:2335

Other Probe Parameters

Sensor Arrangement	Rectangular
Connector Angle (°)	82.5
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	
Tip Diameter	8 mm
Probe Tip to Sensor X Calibration Point	2.5 mm
Probe Tip to Sensor Y Calibration Point	2.5 mm
Probe Tip to Sensor Z Calibration Point	2.5 mm

Certificate No: ER3-2335_Aug16

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FCC ID: ZNFAS110		AC (RF EMISSIONS) TEST REPORT	🕒 LG	Approved by: Quality Manager
Filename: 1M1701230039-07.ZNF	Test Dates: 01/23/2017 - 01/25/2017	DUT Type: Portable Handset		Page 48 of 66
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Schmi Eng	ration Laboratory of id & Partner ineering AG Isstrasse 43, 8004 Zurich, Switzerland	S Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service
The Swis	ed by the Swiss Accreditation Service (SAS) as Accreditation Service is one of the signatories to the EA ral Agreement for the recognition of calibration certificates	
Client	PC Test	Certificate No: CD835V3-1082_May16
CAL	IBRATION CERTIFICATE	
Object	CD835V3 - SN: 1082	

Calibration procedure(s)

QA CAL-20.v6 Calibration procedure for dipoles in air

Calibration date:

May 10, 2016

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

05/25/2016

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter NRP	SN: 104778	06-Apr-16 (No. 217-02288/02289)	Apr-17
Power sensor NRP-Z91	SN: 103244	06-Apr-16 (No. 217-02288)	Apr-17
Power sensor NRP-Z91	SN: 103245	06-Apr-16 (No. 217-02289)	Apr-17
Reference 20 dB Attenuator	SN: 5058 (20k)	05-Apr-16 (No. 217-02292)	Apr-17
Type-N mismatch combination	SN: 5047.2 / 06327	05-Apr-16 (No. 217-02295)	Apr-17
Probe ER3DV6	SN: 2336	31-Dec-15 (No. ER3-2336_Dec15)	Dec-16
Probe H3DV6	SN: 6065	31-Dec-15 (No. H3-6065_Dec15)	Dec-16
DAE4	SN: 781	04-Sep-15 (No. DAE4-781_Sep15)	Sep-16
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power meter Agilent 4419B	SN: GB42420191	09-Oct-09 (in house check Sep-14)	In house check: Oct-17
Power sensor HP E4412A	SN: US38485102	05-Jan-10 (in house check Sep-14)	In house check: Oct-17
Power sensor HP 8482A	SN: US37295597	09-Oct-09 (in house check Sep-14)	In house check: Oct-17
RF generator R&S SMT-06	SN: 832283/011	27-Aug-12 (in house check Oct-15)	In house check: Oct-17
Network Analyzer HP 8753E	SN: US37390585	18-Oct-01 (in house check Oct-15)	In house check: Oct-16
	Name	Function	Signature
Calibrated by:	Jeton Kastrati	Laboratory Technician	deth
Approved by:	Katja Pokovic	Technical Manager	lett

Certificate No: CD835V3-1082_May16

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FCC ID: ZNFAS110		HAC (RF EMISSIONS) TEST REPORT	🕒 LG	Approved by: Quality Manager
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Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS)

Zeughausstrasse 43, 8004 Zurich, Switzerland

Calibration Laboratory of

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

References

[1] ANSI-C63.19-2011

Schmid & Partner

Engineering AG

American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

ac-MR

Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a distance of 15 mm above the top metal edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All
 figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector
 is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a
 directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- Feed Point Impedance and Return Loss: These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E-field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 15 mm (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, in the plane above the dipole surface.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Certificate No: CD835V3-1082_May16

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FCC ID: ZNFAS110		IAC (RF EMISSIONS) TEST REPORT	🕒 LG	Approved by: Quality Manager
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Measurement Conditions

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DASY system configuration, as far as not given	on page 1.	
DASY Version	DASY5	V52.8.8
Phantom	HAC Test Arch	
Distance Dipole Top - Probe Center	15 mm	
Scan resolution	dx, dy = 5 mm	
Frequency	835 MHz ± 1 MHz	
Input power drift	< 0.05 dB	

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Maximum Field values at 835 MHz

E-field 15 mm above dipole surface	condition	Interpolated maximum	
Maximum measured above high end	100 mW input power	107.5 V/m = 40.63 dBV/m	
Maximum measured above low end	100 mW input power	106.1 V/m = 40.51 dBV/m	
Averaged maximum above arm	100 mW input power	106.8 V/m ± 12.8 % (k=2)	

Appendix (Additional assessments outside the scope of SCS 0108)

Antenna Parameters

Frequency	Return Loss	Impedance 44.5 Ω - 13.4 jΩ	
800 MHz	16.4 dB		
835 MHz	26.3 dB	50.0 Ω + 4.9 jΩ	
900 MHz	16.4 dB	57.4 Ω - 14.7 jΩ	
950 MHz	21.9 dB	43.6 Ω + 4.0 jΩ	
960 MHz	17.2 dB	47.9 Ω + 13.5 jΩ	

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

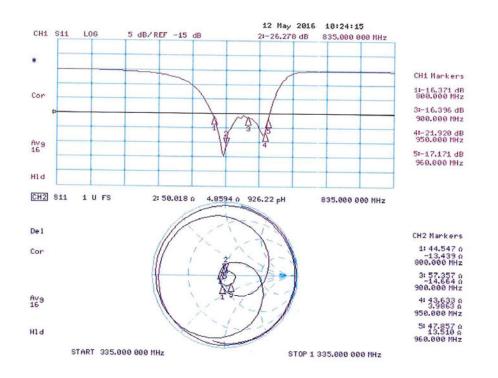
Certificate No: CD835V3-1082_May16

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Impedance Measurement Plot

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02/01/2017

DASY5 E-field Result

Date: 10.05.2016

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Test Laboratory: SPEAG Lab2

DUT: HAC-Dipole 835 MHz; Type: CD835V3; Serial: CD835V3 - SN: 1082

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Communication System: UID 0 - CW ; Frequency: 835 MHz Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³ Phantom section: RF Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY52 Configuration:

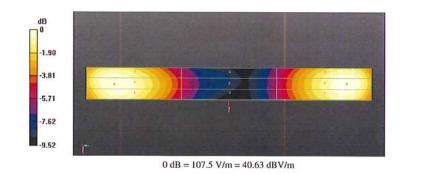
- Probe: ER3DV6 SN2336; ConvF(1, 1, 1); Calibrated: 31.12.2015;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 04.09.2015
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.8.8(1258); SEMCAD X 14.6.10(7372)

Dipole E-Field measurement @ 835MHz/E-Scan - 835MHz d=15mm/Hearing Aid Compatibility Test (41x361x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 109.8 V/m; Power Drift = 0.02 dB Applied MIF = 0.00 dB RF audio interference level = 40.63 dBV/m

Emission category: M3

MIF scaled E-field

	Grid 3 M3 40.46 dBV/m
	Grid 6 M4 35.62 dBV/m
Grid 8 M3 40.51 dBV/m	Grid 9 M3 40.37 dBV/m



Certificate No: CD835V3-1082_May16

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The Swiss Accreditation Servic Multilateral Agreement for the r	ation Service (SAS) e is one of the signatorie ecognition of calibration	s to the EA	ccreditation No.: SCS 0108
Client PC Test			o: CD1880V3-1064_May16
CALIBRATION	CERTIFICAT		
Object	CD1880V3 - SN	: 1064	
Calibration procedure(s)	QA CAL-20.v6 Calibration proce	edure for dipoles in air	05/25/2014
Calibration date:	May 12, 2016		
All calibrations have been condu Calibration Equipment used (M&		ry facility: environment temperature (22 \pm 3)°C	C and humidity < 70%.
Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter NRP	SN: 104778	06-Apr-16 (No. 217-02288/02289)	Apr-17
Power sensor NRP-Z91	SN: 103244	06-Apr-16 (No. 217-02288)	Apr-17
Power sensor NRP-Z91	SN: 103245	06-Apr-16 (No. 217-02289)	Apr-17
Reference 20 dB Attenuator	SN: 5058 (20k)	05-Apr-16 (No. 217-02292)	Apr-17
Type-N mismatch combination Probe ER3DV6	SN: 5047.2 / 06327 SN: 2336	05-Apr-16 (No. 217-02295) 31-Dec-15 (No. ER3-2336_Dec15)	Apr-17
Probe H3DV6	SN: 6065	31-Dec-15 (No. H3-6065_Dec15) 31-Dec-15 (No. H3-6065_Dec15)	Dec-16 Dec-16
DAE4	SN: 781	04-Sep-15 (No. DAE4-781_Sep15)	Sep-16
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power meter Agilent 4419B	SN: GB42420191	09-Oct-09 (in house check Sep-14)	In house check: Oct-17
Power sensor HP E4412A Power sensor HP 8482A	SN: US38485102	05-Jan-10 (in house check Sep-14)	In house check: Oct-17
RF generator R&S SMT-06	SN: US37295597 SN: 832283/011	09-Oct-09 (in house check Sep-14)	In house check: Oct-17
Network Analyzer HP 8753E	SN: US37390585	27-Aug-12 (in house check Oct-15) 18-Oct-01 (in house check Oct-15)	In house check: Oct-17 In house check: Oct-16
	Name	Function	Signature
Calibrated by:	Jeton Kastrati	Laboratory Technician	= 42
		Technical Manager	00111
Approved by:	Katja Pokovic		tot the

Calibration Laboratory of

PCTEST Approved by: FCC ID: ZNFAS110 HAC (RF EMISSIONS) TEST REPORT 🕒 LG Quality Manager Filename: Test Dates: DUT Type: Page 54 of 66 1M1701230039-07.ZNF 01/23/2017 - 01/25/2017 Portable Handset **REV 3.1.M** © 2017 PCTEST Engineering Laboratory, Inc.

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Calibration Laboratory of Schmid & Partner **Engineering AG**

Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

Accreditation No.: SCS 0108

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The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

References

ANSI-C63.19-2011 [1]

American National Standard, Methods of Measurement of Compatibility between Wircless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a distance of 15 mm above the top metal edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy
- Feed Point Impedance and Return Loss: These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles
- E-field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 15 mm (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, in the plane above the dipole surface.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Certificate No: CD1880V3-1064_May16

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Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.8.8
Phantom	HAC Test Arch	
Distance Dipole Top - Probe Center	15 mm	
Scan resolution	dx, dy = 5 mm	
Frequency	1730 MHz ± 1 MHz 1880 MHz ± 1 MHz	
Input power drift	< 0.05 dB	

Maximum Field values at 1730 MHz

E-field 15 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	96.1 V/m = 39.66 dBV/m
Maximum measured above low end	100 mW input power	95.3 V/m = 39.58 dBV/m
Averaged maximum above arm	100 mW input power	95.7 V/m ± 12.8 % (k=2)

Maximum Field values at 1880 MHz

E-field 15 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	91.2 V/m = 39.20 dBV/m
Maximum measured above low end	100 mW input power	88.0 V/m = 38.89 dBV/m
Averaged maximum above arm	100 mW input power	89.6 V/m ± 12.8 % (k=2)

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FCC ID: ZNFAS110		AC (RF EMISSIONS) TEST REPORT	🕒 LG	Approved by: Quality Manager
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Appendix (Additional assessments outside the scope of SCS 0108)

Antenna Parameters

Nominal Frequencies

Frequency	Return Loss	Impedance	
1730 MHz	24.0 dB	49.6 Ω + 6.3 jΩ	
1880 MHz	19.8 dB	49.5 Ω + 10.2 jΩ	
1900 MHz	20.4 dB	52.9 Ω + 9.4 jΩ	
1950 MHz	26.8 dB	54.4 Ω + 1.8 jΩ	
2000 MHz	22.7 dB	43.2 Ω + 0.8 jΩ	

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

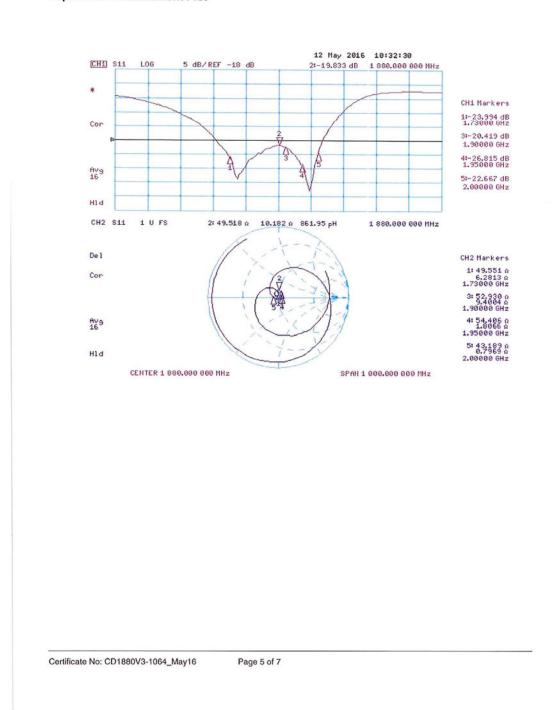
Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

Certificate No: CD1880V3-1064_May16

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Approved by: PCTEST FCC ID: ZNFAS110 HAC (RF EMISSIONS) TEST REPORT 🕒 LG Quality Manager DUT Type: Filename: Test Dates: Page 58 of 66 1M1701230039-07.ZNF 01/23/2017 - 01/25/2017 Portable Handset **REV 3.1.M** © 2017 PCTEST Engineering Laboratory, Inc. 02/01/2017

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Impedance Measurement Plot

DASY5 E-field Result

Date: 10.05.2016

Test Laboratory: SPEAG Lab2

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: CD1880V3 - SN: 1064

Communication System: UID 0 - CW ; Frequency: 1880 MHz, Frequency: 1730 MHz Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Phantom section: RF Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY52 Configuration:

- Probe: ER3DV6 SN2336; ConvF(1, 1, 1); Calibrated: 31.12.2015;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 04.09.2015
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.8.8(1258); SEMCAD X 14.6.10(7372)

Dipole E-Field measurement @ 1880MHz/E-Scan - 1880MHz d=15mm/Hearing Aid Compatibility Test (41x181x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 151.7 V/m; Power Drift = -0.01 dB Applied MIF = 0.00 dB RF audio interference level = 39.20 dBV/m Emission category: M2

MIF scaled E-field

Grid 1 M2	Grid 2 M2	Grid 3 M2
39.04 dBV/m	39.2 dBV/m	39.08 dBV/m
Grid 4 M2	Grid 5 M2	Grid 6 M2
36.76 dBV/m	36.86 dBV/m	36.75 dBV/m
Grid 7 M2		Grid 9 M2
38.68 dBV/m	38.89 dBV/m	38.8 dBV/m

Certificate No: CD1880V3-1064_May16

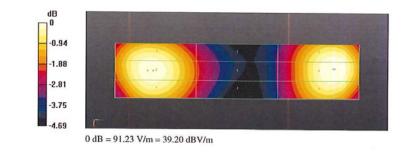
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FCC ID: ZNFAS110		HAC (RF EMISSIONS) TEST REPORT	🕒 LG	Approved by: Quality Manager
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Dipole E-Field measurement @ 1880MHz/E-Scan - 1730MHz d=15mm/Hearing Aid Compatibility Test (41x181x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 168.3 V/m; Power Drift = 0.00 dB Applied MIF = 0.00 dB RF audio interference level = 39.66 dBV/m Emission category: M2

MIF scaled E-field

	Grid 3 M2 39.44 dBV/m
Grid 5 M2 37.56 dBV/m	Grid 6 M2 37.42 dBV/m
Grid 8 M2 39.66 dBV/m	Grid 9 M2 39.57 dBV/m



Certificate No: CD1880V3-1064_May16

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15. CONCLUSION

The measurements indicate that the wireless communications device complies with the HAC limits specified in accordance with the ANSI C63.19 Standard and FCC WT Docket No. 01-309 RM-8658. Precise laboratory measures were taken to assure repeatability of the tests. The tested device complies with the requirements in respect to all parameters specific to the test. The test results and statements relate only to the item(s) tested.

Please note that the M-rating for this equipment only represents the field interference possible against a hypothetical and typical hearing aid. The measurement system and techniques presented in this evaluation are proposed in the ANSI standard as a means of best approximating wireless device compatibility with a hearing-aid. The literature is under continual re-construction.

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16. REFERENCES

- ANSI/IEEE C63.19-2011, "American National Standard for Methods of Measurement of Compatibility between Wireless Communication Devices and Hearing Aids.", New York, NY, IEEE, May 2011
- FCC Office of Engineering and Technology KDB, "285076 D01 HAC Guidance v04," April 26, 2016
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